## Application/Control No. Applicant(s)/Patent Under Reexamination 10/750,355 MATHIEU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Edwin A. León 2833 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,308,252 05-1994 Mroczkowski et al. 439/66 Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-Μ FOREIGN PATENT DOCUMENTS Document Number Date **Classification** Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** \* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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